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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Application Number		10779373	
	Filing Date		2004-02-17	
	First Named Inventor SCHA		AEPKENS, et al.	
	Art Unit		1794	
	Examiner Name	Kevin	R. Kruer	
	Attorney Docket Numb	er	GER01 006 ·	

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